"SN65LVDS95-Q1"

- Qualified for Automotive Applications
- 21:3 Data Channel Compression at up to 1.36 Gigabits per Second Throughput
- Suited for Point-to-Point Subsystem Communication With Very Low EMI
- 21 Data Channels Plus Clock in Low-Voltage TTL and 3 Data Channels Plus Clock Out Low-Voltage Differential
- Operates From a Single 3.3-V Supply and 250 mW (Typ)
- 5-V Tolerant Data Inputs
- 'LVDS95 Has Rising Clock Edge Triggered Inputs
- Bus Pins Tolerate 6-kV HBM ESD
- Packaged in Thin Shrink Small-Outline Package With 20 Mil Terminal Pitch
- Consumes <1 mW When Disabled
- Wide Phase-Lock Input Frequency Range 20 MHz to 68 MHz
- No External Components Required for PLL
- Inputs Meet or Exceed the Requirements of ANSI EIA/TIA-644 Standard
- Industrial Temperature Qualified

  $T_A = -40°C$ to $85°C$
- Replacement for the National DS90CR215

DGG PACKAGE
(TOP VIEW)

D4	1		48	D3
V_{CC}	2		47	D2
D5	3		46	GND
D6	4		45	D1
GND	5		44	D0
D7	6		43	NC
D8	7		42	LVDSGND
V_{CC}	8		41	Y0M
D9	9		40	Y0P
D10	10		39	Y1M
GND	11		38	Y1P
D11	12		37	$LVDSV_{CC}$
D12	13		36	LVDSGND
V_{CC}	14		35	Y2M
D13	15		34	Y2P
D14	16		33	CLKOUTM
GND	17		32	CLKOUTP
D15	18		31	LVDSGND
D16	19		30	PLLGND
D17	20		29	$PLLV_{CC}$
V_{CC}	21		28	PLLGND
D18	22		27	SHTDN
D19	23		26	CLKIN
GND	24		25	D20

description/ordering information

The SN65LVDS95 LVDS serdes (serializer/deserializer) transmitter contains three 7-bit parallel-load serial-out shift registers, a 7× clock synthesizer, and four low-voltage differential signaling (LVDS) line drivers in a single integrated circuit. These functions allow 21 bits of single-ended LVTTL data to be synchronously transmitted over 4 balanced-pair conductors for receipt by a compatible receiver, such as the SN65LVDS96.

ORDERING INFORMATION[†]

T_A	PACKAGE[‡]		ORDERABLE PART NUMBER	TOP-SIDE MARKING
−40°C to 85°C	TSSOP – DGG	Tape and reel	SN65LVDS95DGGRQ1	65LVDS95Q

[†] For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at http://www.ti.com.

[‡] Package drawings, thermal data, and symbolization are available at http://www.ti.com/packaging.

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SN65LVDS95-Q1
LVDS SERDES TRANSMITTER

description/ordering information (continued)

When transmitting, data bits D0 through D20 are each loaded into registers of the SN65LVDS95 on the rising edge of the input clock signal (CLKIN). The frequency of CLKIN is multiplied seven times and then used to serially unload the data registers in 7-bit slices. The three serial streams and a phase-locked clock (CLKOUT) are then output to LVDS output drivers. The frequency of CLKOUT is the same as the input clock, CLKIN.

The SN65LVDS95 requires no external components and little or no control. The data bus appears the same at the input to the transmitter and output of the receiver with data transmission transparent to the user(s). The only user intervention is the possible use of the shutdown/clear ($\overline{\text{SHTDN}}$) active-low input to inhibit the clock and shut off the LVDS output drivers for lower power consumption. A low level on this signal clears all internal registers to a low level.
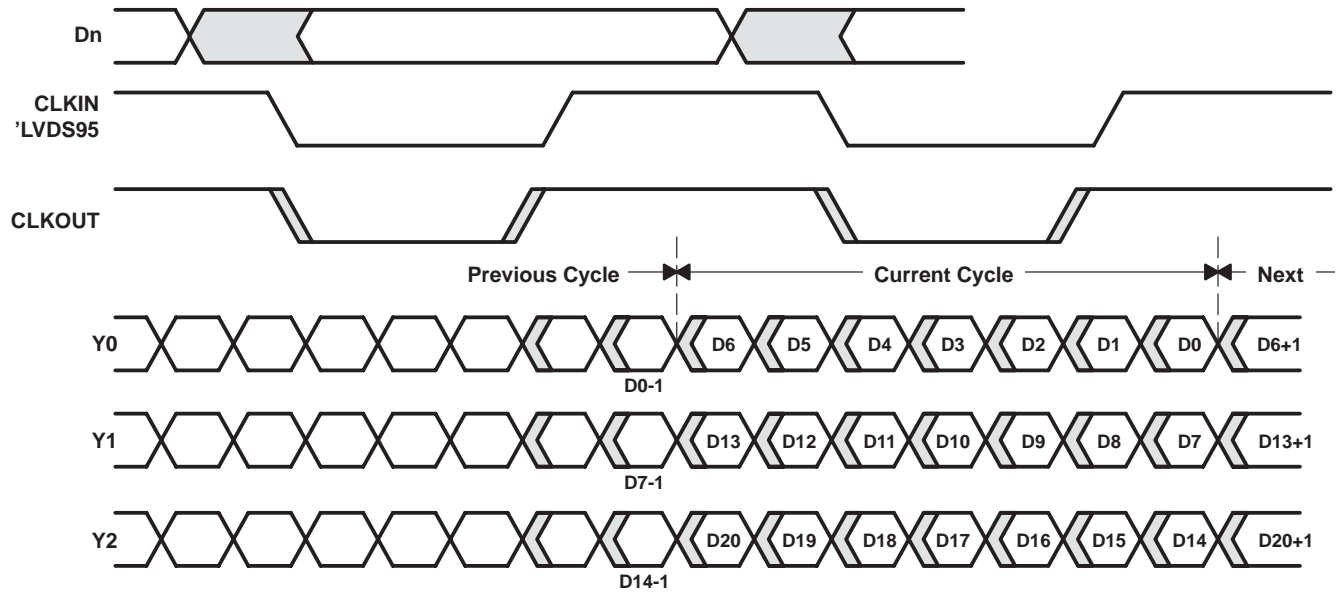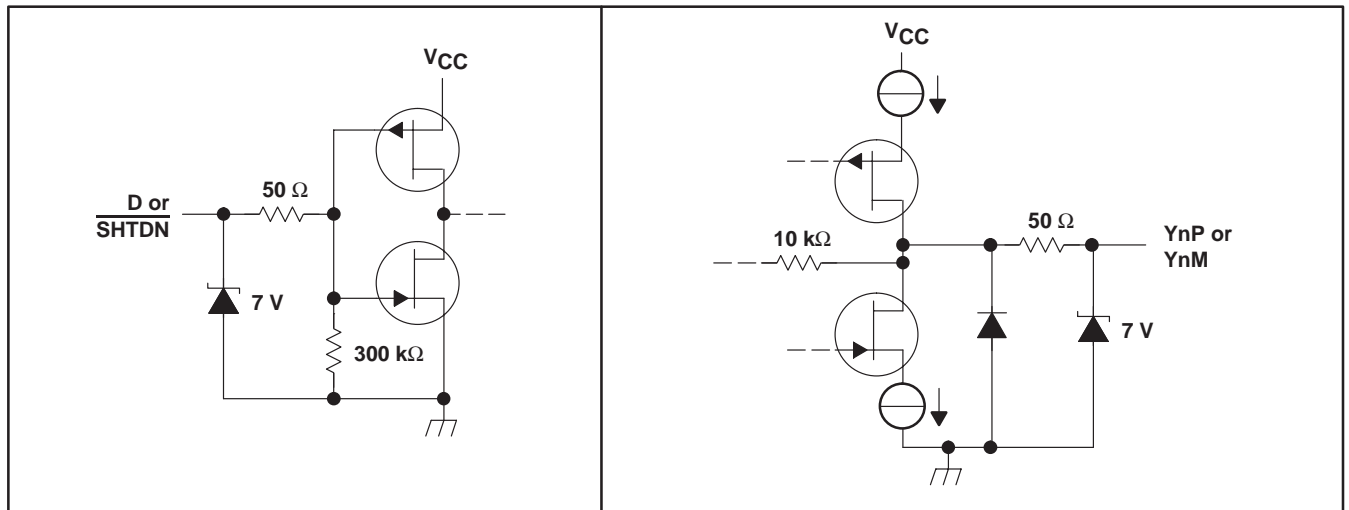
functional block diagram
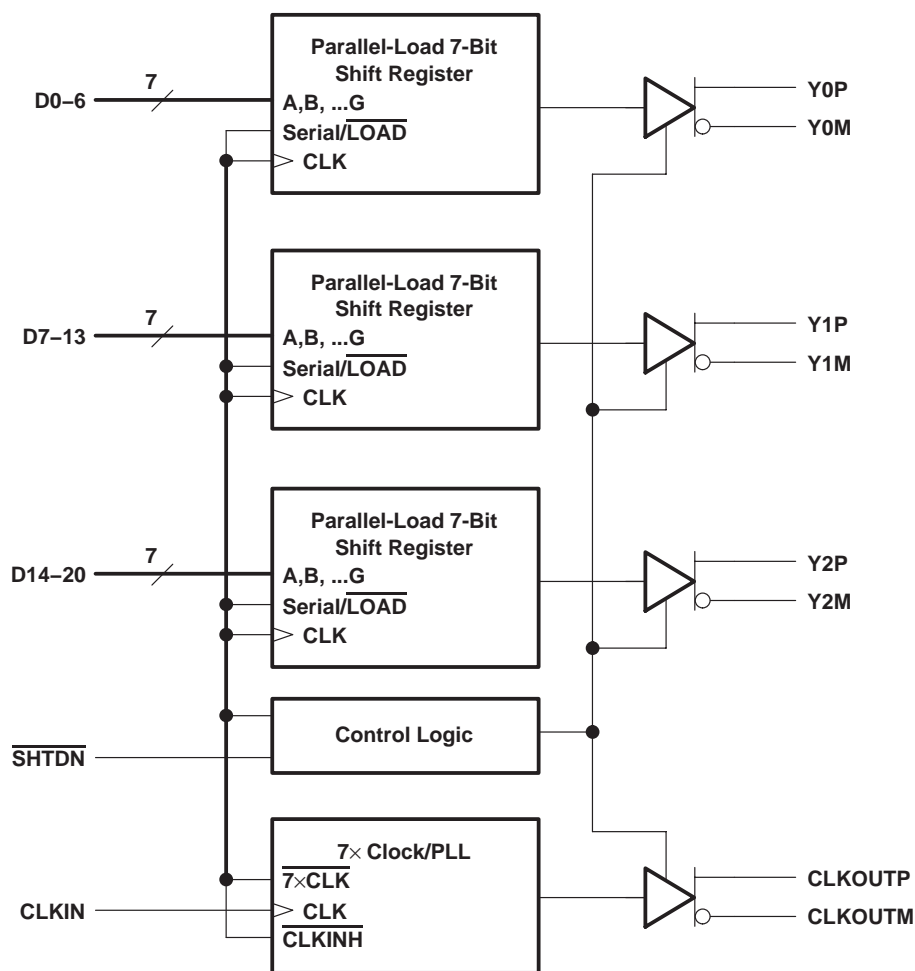
Figure 1. 'LVDS95 Load and Shift Sequences

equivalent input and output schematic diagrams

SN65LVDS95-Q1
LVDS SERDES TRANSMITTER

absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V_{CC} (see Note 1) . . . . −0.5 V to 4 V
Voltage range at any output terminal, V_O . . . . −0.5 V to V_{CC} + 0.5 V
Voltage range at any input terminal, V_I . . . . −0.5 V to 5.5 V
Electrostatic discharge (see Note 2): Bus pins (Class 3A) . . . . 6 KV
Bus pins (Class 2B) . . . . 400 V
All pins (Class 3A) . . . . 6 KV
All pins (Class 2B) . . . . 200 V
Continuous total power dissipation . . . . (see Dissipation Rating Table)
Operating free-air temperature range, T_A . . . . −40°C to 85°C
Storage temperature range, T_{stg} . . . . −65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds . . . . 260°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and
functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not
implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
NOTES: 1. All voltage values are with respect to the GND terminals.
2. This rating is measured using MIL-STD-883C Method, 3015.7.

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25°C$ POWER RATING	DERATING FACTOR‡ ABOVE $T_A = 25°C$	$T_A = 70°C$ POWER RATING	$T_A = 85°C$ POWER RATING
DGG	1316 mW	13.1 mW/°C	724 mW	526 mW

‡ This is the inverse of the junction-to-ambient thermal resistance when board-mounted and with no air flow.

recommended operating conditions

	MIN	NOM	MAX	UNIT
Supply voltage, V_{CC}	3	3.3	3.6	V
High-level input voltage, V_{IH}	2			V
Low-level input voltage, V_{IL}			0.8	V
Differential load impedance, Z_L	90		132	Ω
Operating free-air temperature, T_A	−40		85	°C

TEXAS INSTRUMENTS

electrical characteristics over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	UNIT
V_{IT}	Input voltage threshold			1.4		V
$|V_{OD}|$	Differential steady-state output voltage magnitude	R_L = 100 Ω, See Figure 3	247		454	mV
$\Delta|V_{OD}|$	Change in the steady-state differential output voltage magnitude between opposite binary states				50	
$V_{OC(SS)}$	Steady-state common-mode output voltage	See Figure 3	1.125		1.375	V
$V_{OC(PP)}$	Peak-to-peak common-mode output voltage			80	150	mV
I_{IH}	High-level input current	$V_{IH} = V_{CC}$			20	μA
I_{IL}	Low-level input current	V_{IL} = 0 V			±10	μA
I_{OS}	Short-circuit output current	V_{OY} = 0 V			±24	mA
		V_{OD} = 0 V			±12	mA
I_{OZ}	High-impedance state output current	V_O = 0 V to V_{CC}			±10	μA
$I_{CC(AVG)}$	Quiescent current (average)	Disabled, all inputs at GND			280	μA
		Enabled, R_L = 100 Ω (4 places), Worst-case pattern (see Figure 4), t_C = 15.38 ns		85	110	mA
C_i	Input capacitance			3		pF

† All typical values are V_{CC} = 3.3 V, T_A = 25°C.

timing requirements

		MIN	NOM	MAX	UNIT
t_C	Input clock period	14.7	t_C	50	ns
t_W	High-level input clock pulse width duration	$0.4t_C$		$0.6t_C$	ns
t_t	Input signal transition time			5	ns
t_{su}	Data setup time, D0 through D27 before CLKIN↑ ('95) (see Figure 2)	3			ns
t_h	Data hold time, D0 through D27 after CLKIN↑ ('95) (see Figure 2)	1.5			ns

switching characteristics over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP[†]	MAX	UNIT
t_0	Delay time, CLKOUT serial bit position 0		−0.20	0	0.20	ns
t_1	Delay time, CLKOUT↑ serial bit position 1		$1/7t_C$−0.20		$1/7t_C$+0.20	ns
t_2	Delay time, CLKOUT↑ serial bit position 2		$2/7t_C$−0.20		$2/7t_C$+0.20	ns
t_3	Delay time, CLKOUT↑ serial bit position 3	t_C = 15.38 ns (±0.2%),	$3/7t_C$−0.20		$3/7t_C$+0.20	ns
t_4	Delay time, CLKOUT↑ serial bit position 4	|Input clock jitter| < 50 ps[‡],	$4/7t_C$−0.20		$4/7t_C$+0.20	ns
t_5	Delay time, CLKOUT↑ serial bit position 5	See Figure 5	$5/7t_C$−0.20		$5/7t_C$+0.20	ns
t_6	Delay time, CLKOUT↑ serial bit position 6		$6/7t_C$−0.20		$6/7t_C$+0.20	ns
$t_{sk(o)}$	Output skew, t_n −n/7 t_C		−0.20		0.20	ns
t_7	Delay time, CLKIN↑ to CLKOUT↑	t_C = 15.38 ns (±0.2%), |Input clock jitter| < 50 ps[‡], See Figure 5		4.2		ns
$\Delta t_{C(O)}$	Output clock cycle-to-cycle jitter[§]	t_C = 15.38 ns + 0.75 sin(2π500E3t) ±0.05 ns, See Figure 6		±80		ps
		t_C = 15.38 ns + 0.75 sin(2π2E6t) ±0.05 ns, See Figure 6		±300		ps
t_w	High-level output clock pulse duration			4/7 t_C		ns
t_t	Differential output voltage transition time (t_r or t_f)	See Figure 3	260	700	1500	ps
t_{en}	Enable time, $\overline{SHTDN}$↑ to phase lock (Yn valid)	See Figure 7		1		ms
t_{dis}	Disable time, $\overline{SHTDN}$↓ to off-state (CLKOUT low)	See Figure 8		250		ns

[†] All typical values are V_{CC} = 3.3 V, T_A = 25°C.
[‡] \|Input clock jitter\| is the magnitude of the change in the input clock period.
[§] The output clock jitter is the change in the output clock period from one cycle to the next cycle observed over 15,000 cycles.

PARAMETER MEASUREMENT INFORMATION
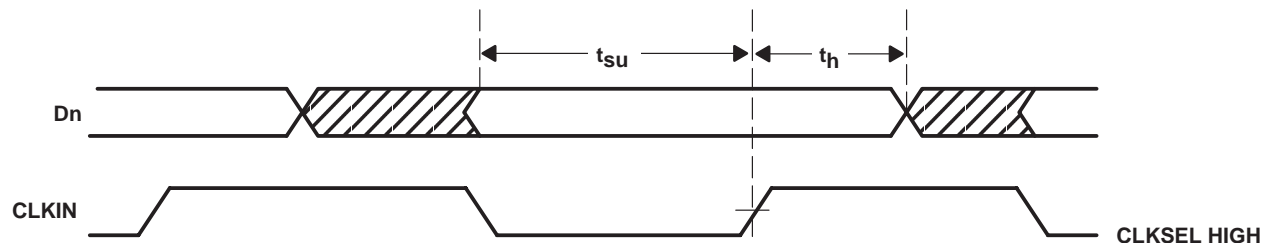
NOTE: All input timing is defined at 1.4 V on an input signal with a 10% to 90% rise or fall time of less than 5 ns.

Figure 2. Setup and Hold Time Definition

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PARAMETER MEASUREMENT INFORMATION

NOTE: The lumped instrumentation capacitance for any single ended voltage measurement is less than or equal to 10 pF. When making measurements at YP or YM, the complementary output shall be similarly loaded.
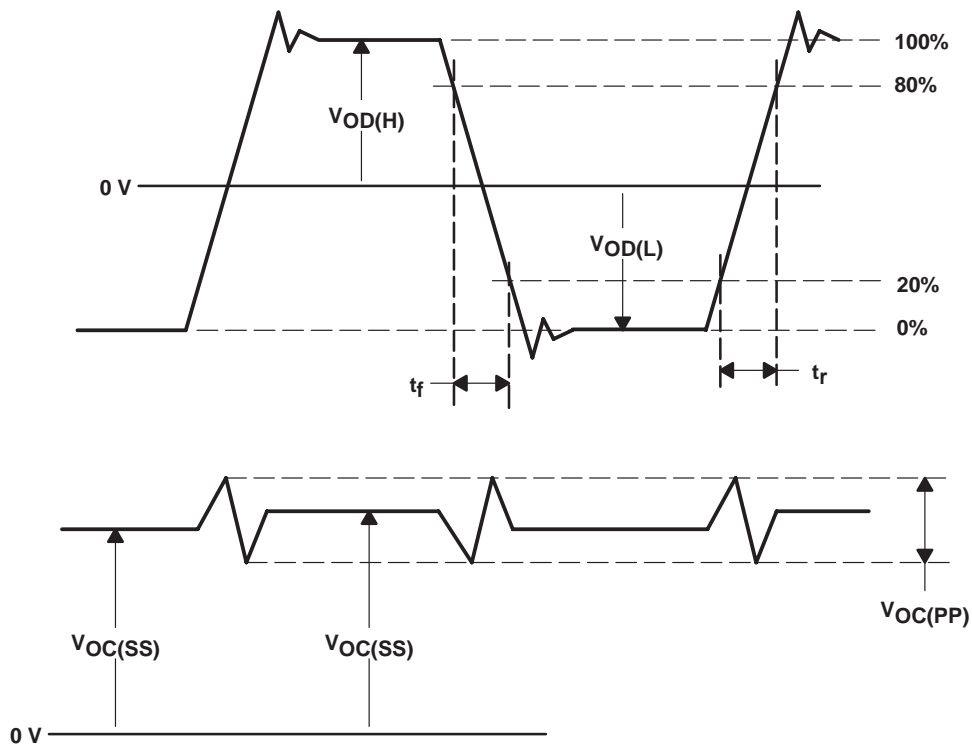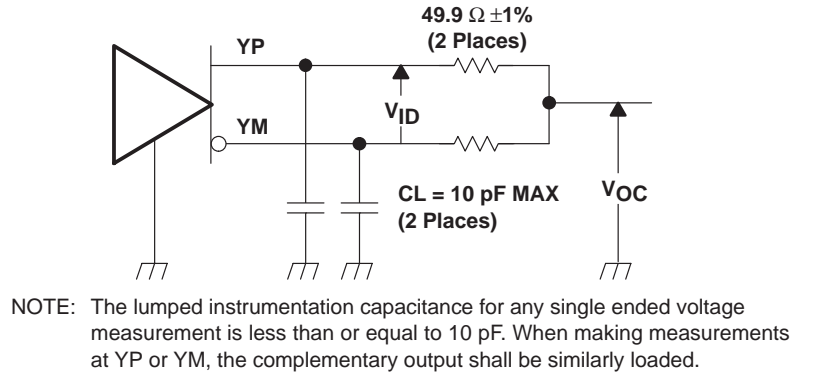

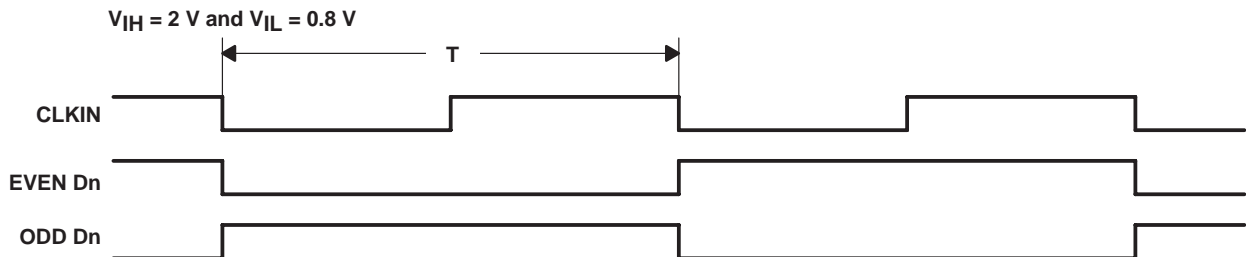**Figure 3. Test Load and Voltage Definitions for LVDS Outputs**

Figure 4. Worst-Case‡ Power Test Pattern

‡ The worst-case test pattern produces nearly the maximum switching frequency for all of the LV-TTL outputs.

PARAMETER MEASUREMENT INFORMATION
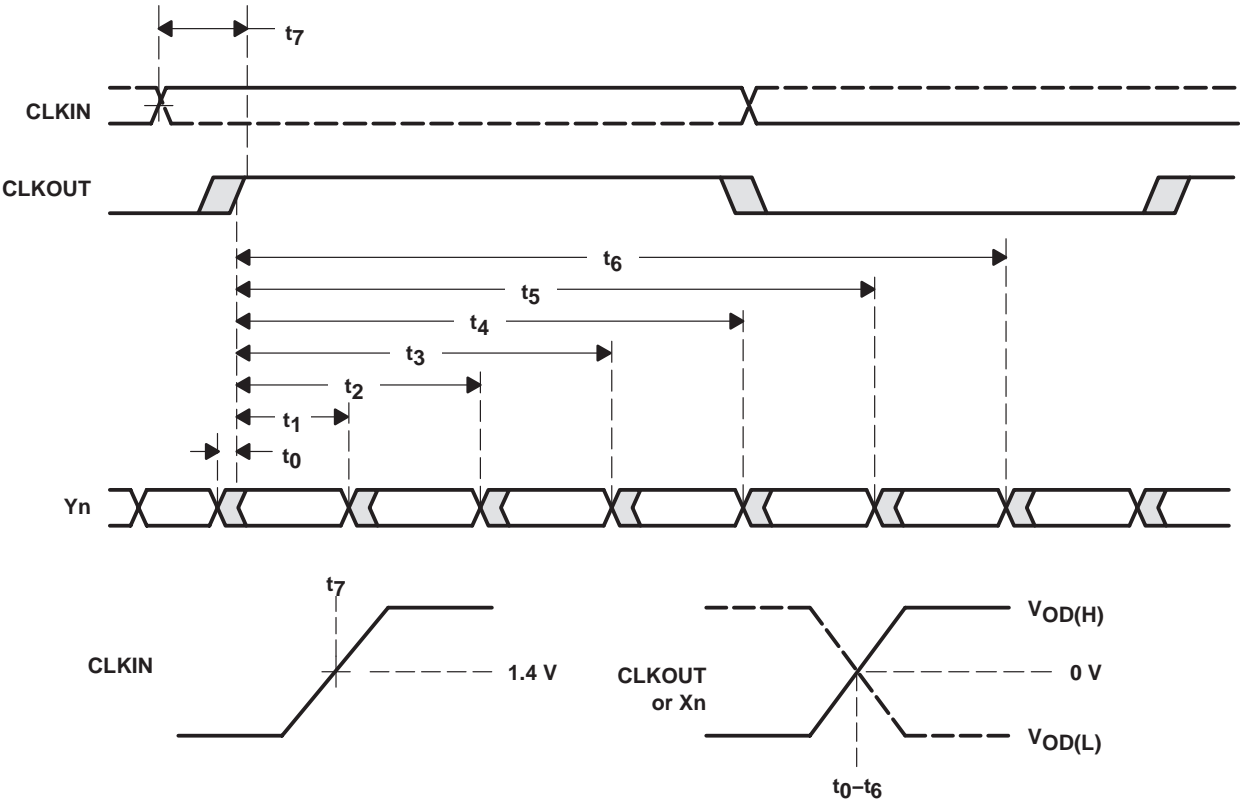
Figure 5. Timing Definitions

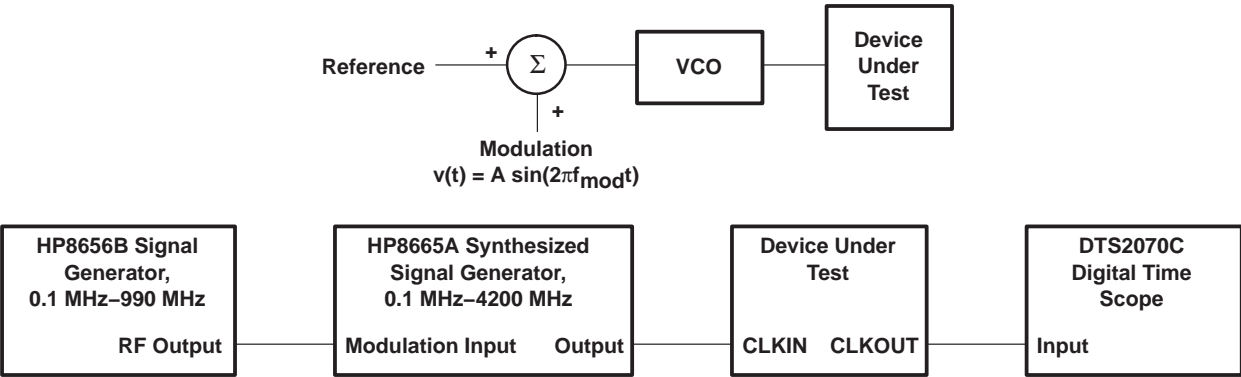**Figure 6. Clock Jitter Test Setup**

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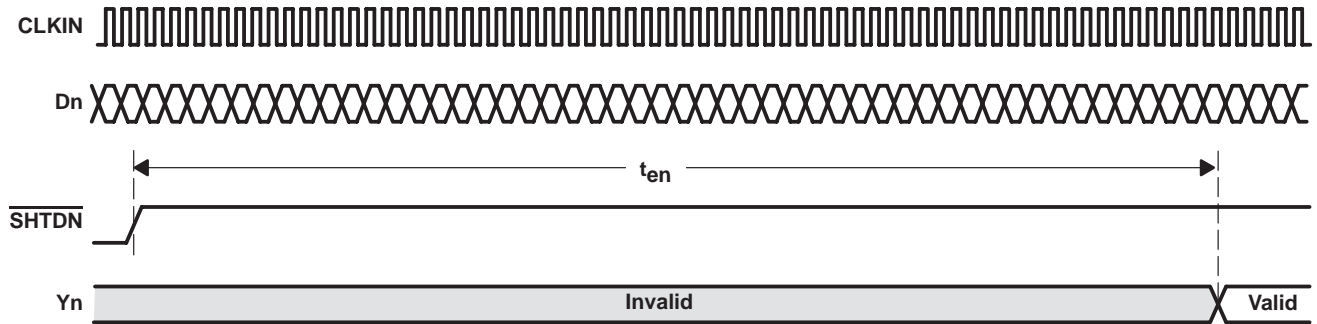## PARAMETER MEASUREMENT INFORMATION

Figure 7. Enable Time Measurement Definition
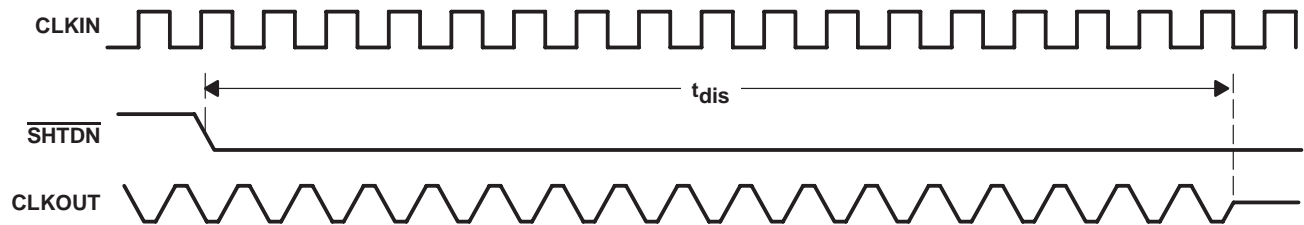
Figure 8. Disable Time Measurement Definition
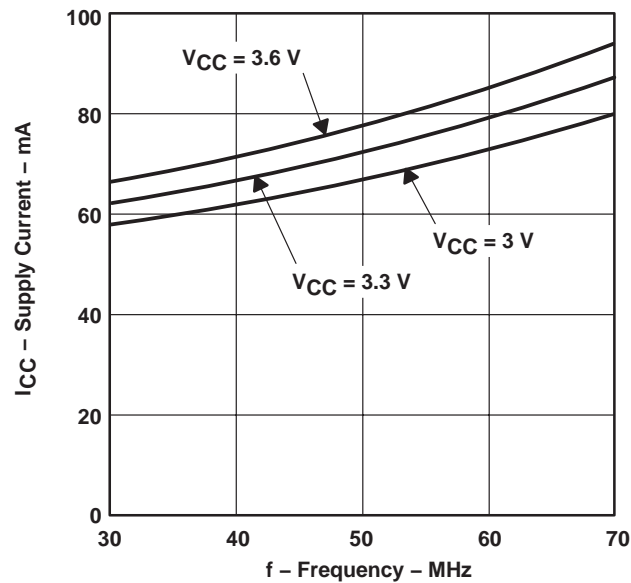
TYPICAL CHARACTERISTICS

WORST-CASE SUPPLY CURRENT
vs
FREQUENCY

Figure 9

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9

APPLICATION INFORMATION

16-bit bus extension

In a 16-bit bus application (Figure 10), TTL data and clock coming from bus transceivers that interface the backplane bus arrive at the Tx parallel inputs of the LVDS serdes transmitter. The clock associated with the bus is also connected to the device. The on-chip PLL synchronizes this clock with the parallel data at the input. The data is then multiplexed into three different line drivers which perform the TTL to LVDS conversion. The clock is also converted to LVDS and presented to a separate driver. This synchronized LVDS data and clock at the receiver, which recovers the LVDS data and clock, performs a conversion back to TTL. Data is then demultiplexed into a parallel format. An on-chip PLL synchronizes the received clock with the parallel data, and then all are presented to the parallel output port of the receiver.
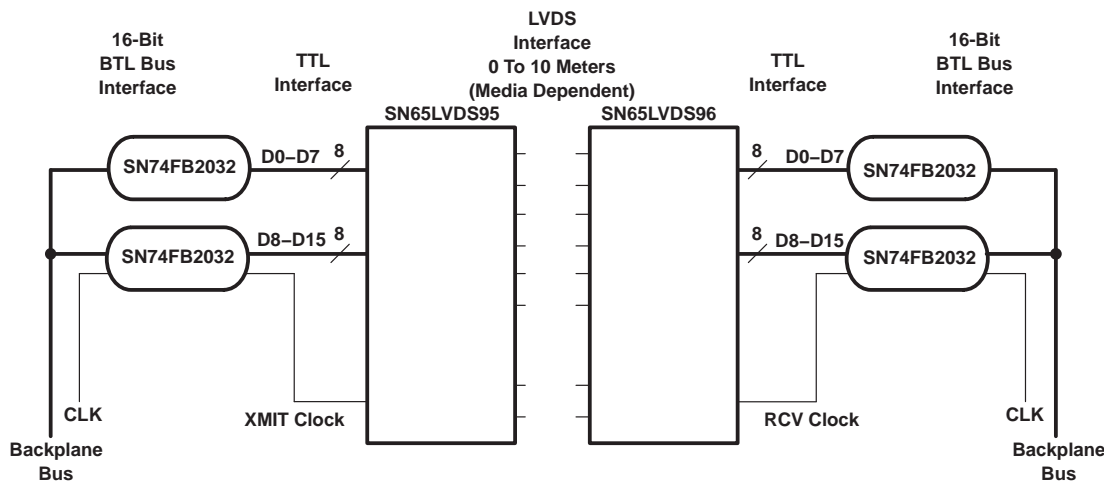
Figure 10. 16-Bit Bus Extension

16-bit bus extension with parity

In the previous application we did not have a checking bit that would provide assurance that the data crosses the link. If we add a parity bit to the previous example, we would have a diagram similar to the one in Figure 11. The device following the SN74FB2032 is a low cost parity generator. Each transmit-side transceiver/parity generator takes the LVTTL data from the corresponding transceiver, performs a parity calculation over the byte, and then passes the bits with its calculated parity value on the parallel input of the LVDS serdes transmitter. Again, the on-chip PLL synchronizes this transmit clock with the eighteen parallel bits (16 data + 2 parity) at the input. The synchronized LVDS data/parity and clock arrive at the receiver.

The receiver performs the conversion from LVDS to LVTTL and the transceiver/parity generator performs the parity calculations. These devices compare their corresponding input bytes with the value received on the parity bit. The transceiver/parity generator will assert its parity error output if a mismatch is detected.

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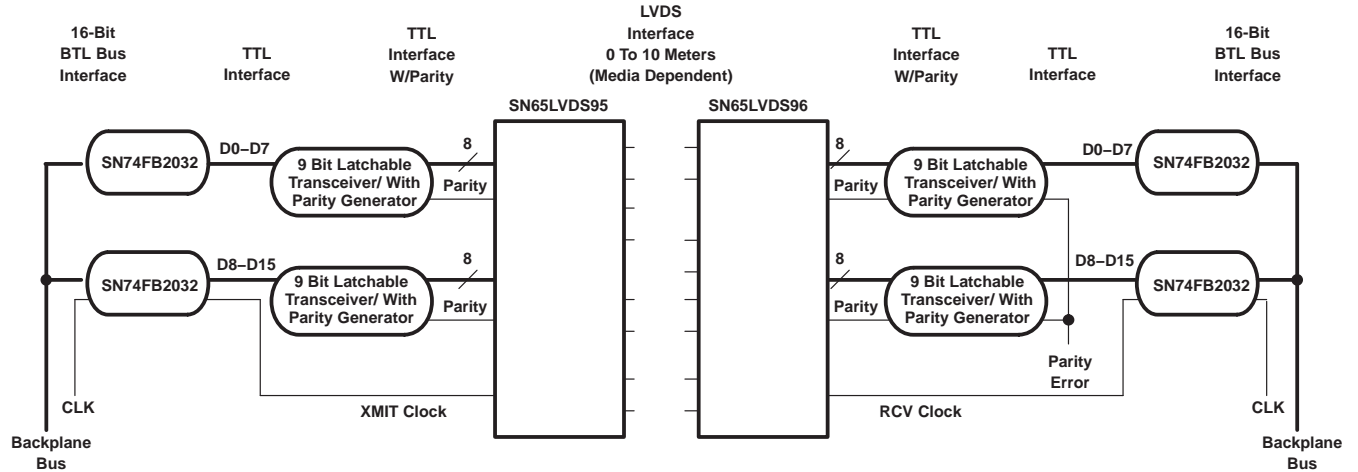## APPLICATION INFORMATION

Figure 11. 16-Bit Bus Extension With Parity

low cost virtual backplane transceiver

Figure 12 represents LVDS serdes in an application as a virtual backplane transceiver (VBT). The concept of a VBT can be achieved by implementing individual LVDS serdes chipsets in both directions of subsystem serialized links.

Depending on the application, the designer will face varying choices when implementing a VBT. In addition to the devices shown in Figure 12, functions such as parity and delay lines for control signals could be included. Using additional circuitry, half-duplex or full-duplex operation can be achieved by configuring the clock and control lines properly.

The designer may choose to implement an independent clock oscillator at each end of the link and then use a PLL to synchronize LVDS serdes's parallel I/O to the backplane bus. Resynchronizing FIFOs may also be required.
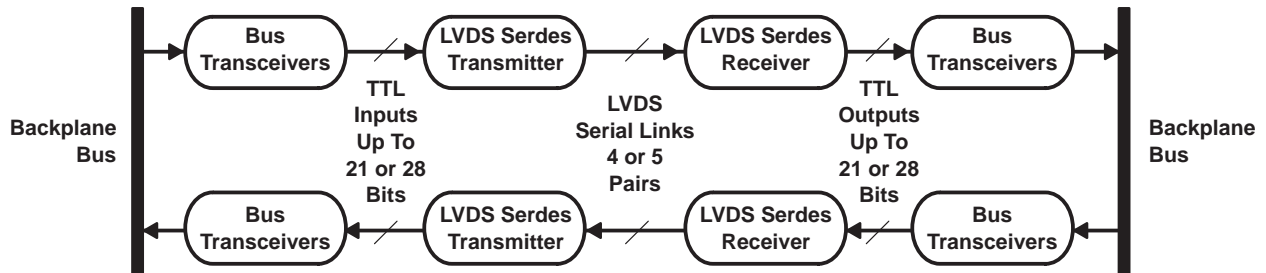

Figure 12. Virtual Backplane Transceiver

PACKAGING INFORMATION

Orderable Device	Status [1]	Package Type	Package Drawing	Pins	Package Qty	Eco Plan [2]	Lead/Ball Finish	MSL Peak Temp [3]
SN65LVDS95DGGRQ1	ACTIVE	TSSOP	DGG	48	2000	TBD	CU NIPDAU	Level-1-250C-UNLIM

[1] The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

[2] Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

[3] MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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OTHER QUALIFIED VERSIONS OF SN65LVDS95-Q1 :
● Catalog: SN65LVDS95
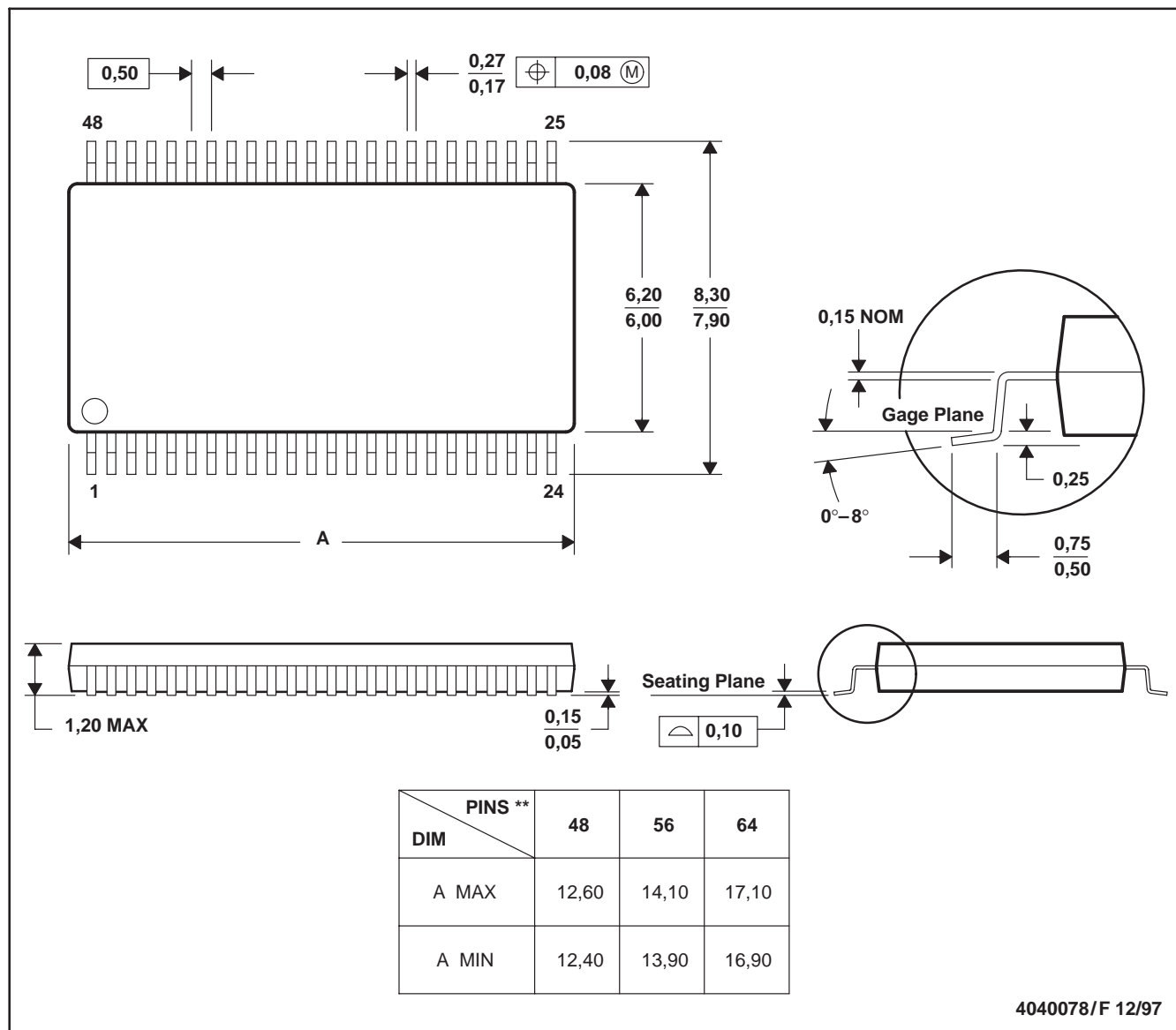● Enhanced Product: SN65LVDS95-EP

NOTE: Qualified Version Definitions:
  ● Catalog - TI's standard catalog product
  ● Enhanced Product - Supports Defense, Aerospace and Medical Applications

"SN65LVDS95-Q1"

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN

PINS ** DIM	48	56	64
A MAX	12,60	14,10	17,10
A MIN	12,40	13,90	16,90

4040078 / F 12/97

NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold protrusion not to exceed 0,15.
D. Falls within JEDEC MO-153

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Microcontrollers	microcontroller.ti.com	Security	www.ti.com/security
RFID	www.ti-rfid.com	Telephony	www.ti.com/telephony
RF/IF and ZigBee® Solutions	www.ti.com/lprf	Video & Imaging	www.ti.com/video
		Wireless	www.ti.com/wireless